

**Search Notes**

Application/Control No.

10/645,249

Examiner

Justin Krause

Applicant(s)/Patent under  
Reexamination

TAKAHASHI ET AL.

Art Unit

3682

**SEARCHED**

Class	Subclass	Date	Examiner
Update	Above	1/20/2007	JMK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR